

3.2 V OPERATION SILICON RF POWER LDMOS FET FOR GSM/DCS DUAL-BAND PHONE TRANSMISSION AMPLIFIERS

DESCRIPTION

The NE5520379A is an N-channel silicon power MOS FET specially designed as the transmission power amplifier for 3.2 V GSM 900 handsets. Dies are manufactured using our NEWMOS technology and housed in a surface mount package. This device can deliver 34.6 dBm output power with 68% power efficiency at 915 MHz under the 2.8 V supply voltage.

FEATURES

- High output power : $P_{out} = 35.5$ dBm TYP. ($V_{DS} = 3.2$ V, $V_{GS} = 2.5$ V, $f = 915$ MHz, $P_{in} = 25$ dBm)
: $P_{out} = 33.0$ dBm TYP. ($V_{DS} = 3.2$ V, $V_{GS} = 2.5$ V, $f = 1\ 785$ MHz, $P_{in} = 25$ dBm)
- High power added efficiency : $\eta_{add} = 65\%$ TYP. ($V_{DS} = 3.2$ V, $V_{GS} = 2.5$ V, $f = 915$ MHz, $P_{in} = 25$ dBm)
: $\eta_{add} = 35\%$ TYP. ($V_{DS} = 3.2$ V, $V_{GS} = 2.5$ V, $f = 1\ 785$ MHz, $P_{in} = 25$ dBm)
- High linear gain : $G_L = 16.0$ dB TYP. ($V_{DS} = 3.2$ V, $V_{GS} = 2.5$ V, $f = 915$ MHz, $P_{in} = 10$ dBm)
: $G_L = 8.5$ dB TYP. ($V_{DS} = 3.2$ V, $V_{GS} = 2.5$ V, $f = 1\ 785$ MHz, $P_{in} = 10$ dBm)
- Surface mount package : $5.7 \times 5.7 \times 1.1$ mm MAX.
- ★ • Single supply : $V_{DS} = 2.8$ to 6.0 V

APPLICATIONS

- Digital cellular phones : 3.2 V GSM/DCS Dual-Band handsets
- Others : General purpose amplifiers for 1.6 to 2.0 GHz TDMA applications

ORDERING INFORMATION

Part Number	Package	Marking	Supplying Form
NE5520379A-T1	79A	A3	<ul style="list-style-type: none"> 12 mm wide embossed taping Gate pin face the perforation side of the tape Qty 1 kpcs/reel
NE5520379A-T1A			<ul style="list-style-type: none"> 12 mm wide embossed taping Gate pin face the perforation side of the tape Qty 5 kpcs/reel

Remark To order evaluation samples, contact your nearby sales office.

Part number for sample order: NE5520379A

Caution Observe precautions when handling because these devices are sensitive to electrostatic discharge.

The information in this document is subject to change without notice. Before using this document, please confirm that this is the latest version.
Not all devices/types available in every country. Please check with local NEC Compound Semiconductor Devices representative for availability and additional information.

ABSOLUTE MAXIMUM RATINGS ($T_A = +25^{\circ}\text{C}$)

Parameter	Symbol	Ratings	Unit
★ Drain to Source Voltage	V_{DS}	15.0	V
Gate to Source Voltage	V_{GS}	5.0	V
Drain Current	I_D	1.5	A
Drain Current (Pulse Test)	$I_{D \text{ Note}}$	3.0	A
Total Power Dissipation	P_{tot}	20	W
Channel Temperature	T_{ch}	125	$^{\circ}\text{C}$
Storage Temperature	T_{stg}	-65 to +125	$^{\circ}\text{C}$

Note Duty Cycle $\leq 50\%$, $T_{on} \leq 1 \text{ s}$

RECOMMENDED OPERATING CONDITIONS

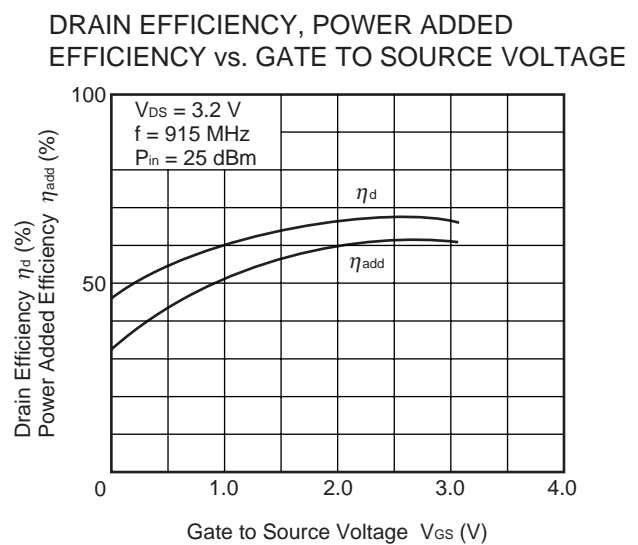
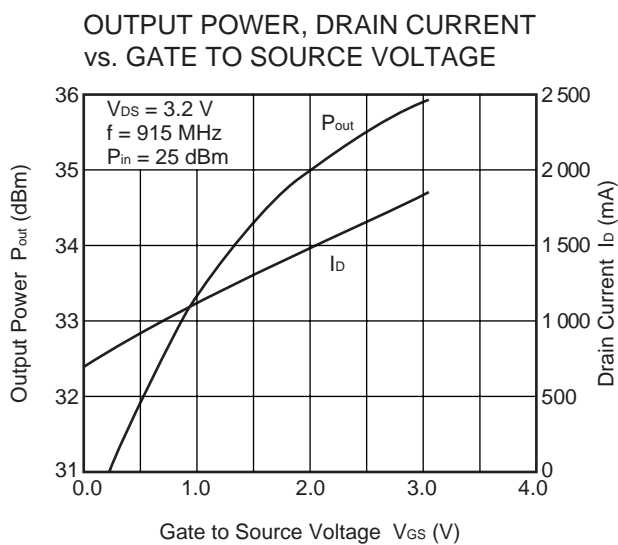
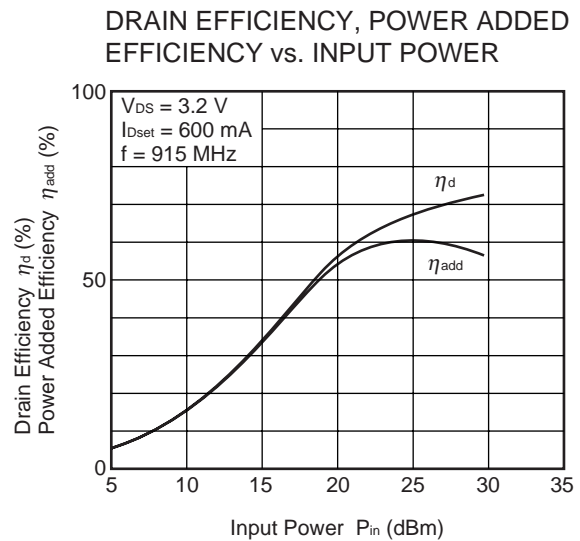
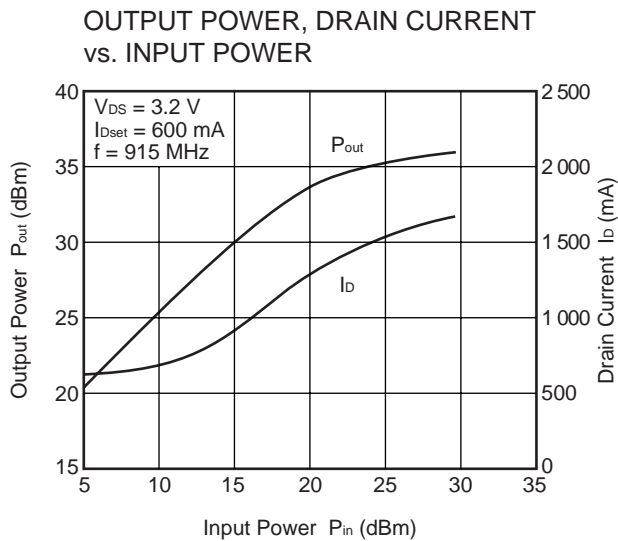
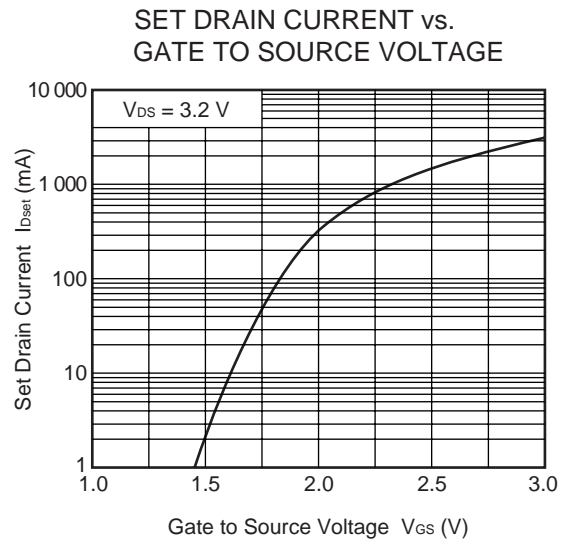
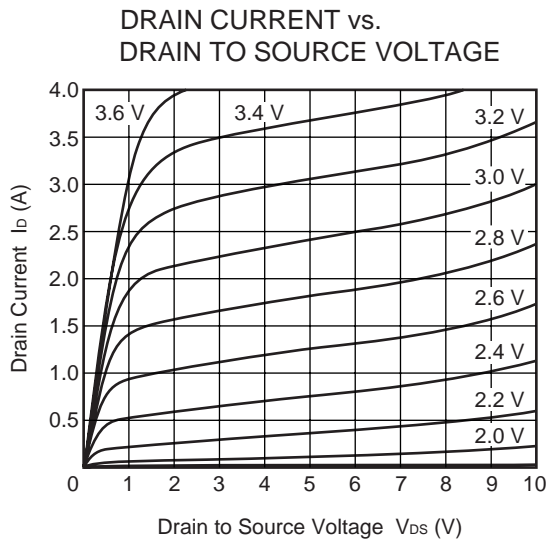
Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
★ Drain to Source Voltage	V_{DS}		2.8	3.2	6.0	V
Gate to Source Voltage	V_{GS}		0	2.5	3.5	V
Drain Current (Pulse Test)	I_D	Duty Cycle $\leq 50\%$, $T_{on} \leq 1 \text{ s}$	—	1.75	2.0	A
Input Power	P_{in}	$f = 1.8 \text{ GHz}$, $V_{DS} = 3.6 \text{ V}$	24	25	26	dBm

ELECTRICAL CHARACTERISTICS (T_A = +25°C)

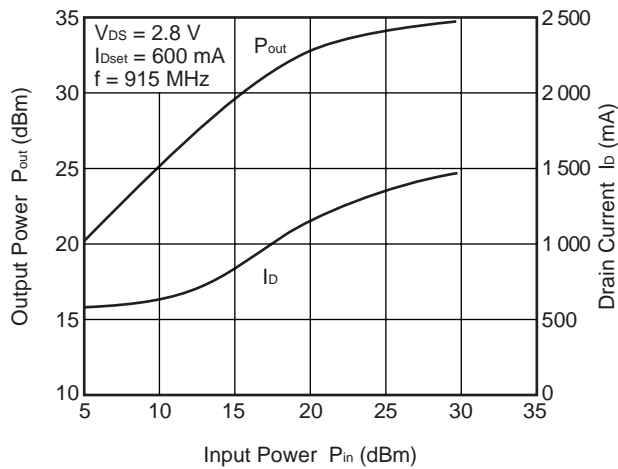
	Parameter	Symbol	Test Conditions	MIN.	TYP.	MAX.	Unit
★	Gate to Source Leak Current	I _{GSS}	V _{GS} = 6.0 V	–	–	100	nA
★	Drain to Source Leakage Current (Zero Gate Voltage Drain Current)	I _{DSS}	V _{DS} = 8.5 V	–	–	100	nA
	Gate Threshold Voltage	V _{th}	V _{DS} = 3.5 V, I _D = 1 mA	1.0	1.35	2.0	V
	Transconductance	G _m	V _{DS} = 3.5 V, I _D = 0.8 to 1.0 A	–	2.5	–	S
	Drain to Source Breakdown Voltage	BV _{DSS}	I _{DSS} = 10 μA	15	20	–	V
	Thermal Resistance	R _{th}	Channel to Case	–	–	5	°C/W
	Linear Gain	G _L	f = 915 MHz, P _{in} = 10 dBm, V _{DS} = 3.2 V, V _{GS} = 2.5 V, Note	–	16.0	–	dB
	Output Power	P _{out}	f = 915 MHz, P _{in} = 25 dBm, V _{DS} = 3.2 V, V _{GS} = 2.5 V, Note	–	35.5	–	dBm
	Drain Efficiency	η _d		–	68	–	%
	Power Added Efficiency	η _{add}		–	65	–	%
	Linear Gain	G _L	f = 1 785 MHz, P _{in} = 10 dBm, V _{DS} = 3.2 V, V _{GS} = 2.5 V, Note	–	8.5	–	dB
	Output Power	P _{out}	f = 1 785 MHz, P _{in} = 25 dBm, V _{DS} = 3.2 V, V _{GS} = 2.5 V, Note	31.0	33.0	–	dBm
	Drain Efficiency	η _d		29	38	–	%
	Power Added Efficiency	η _{add}		–	35	–	%

Note DC performance is 100% testing. RF performance is testing several samples per wafer.
Wafer rejection criteria for standard devices is 1 reject for several samples.

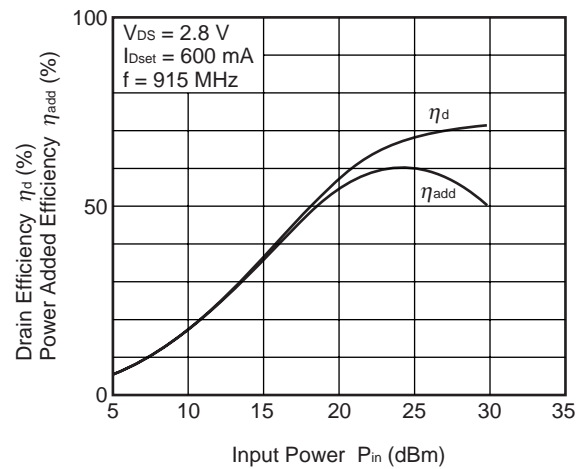
★ TYPICAL CHARACTERISTICS ($T_A = +25^\circ\text{C}$)



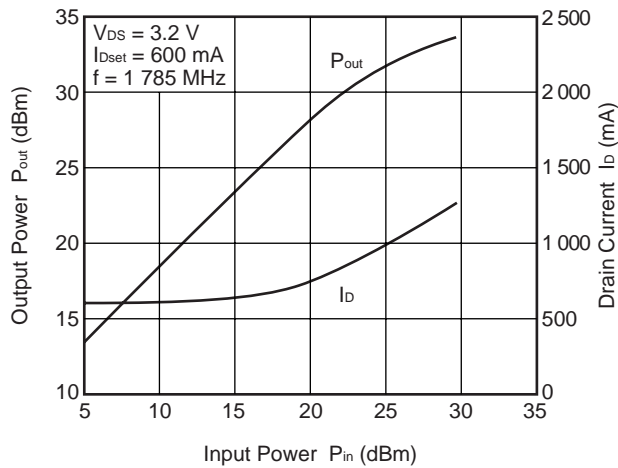
OUTPUT POWER, DRAIN CURRENT
vs. INPUT POWER (915 MHz)



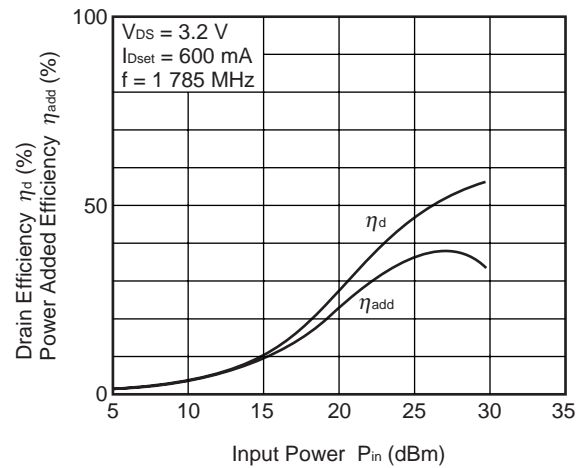
DRAIN EFFICIENCY, POWER ADDED
EFFICIENCY vs. INPUT POWER



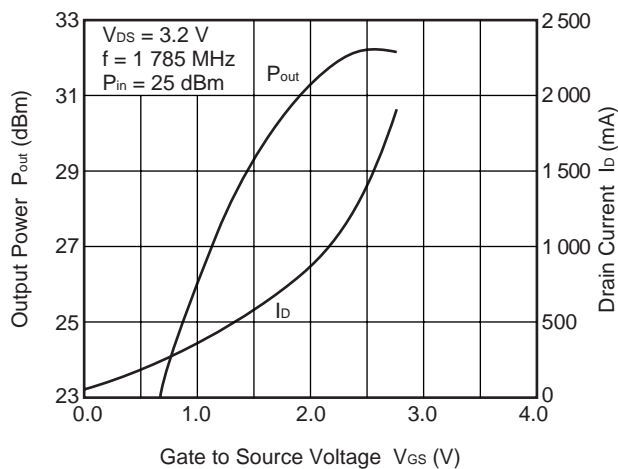
OUTPUT POWER, DRAIN CURRENT
vs. INPUT POWER (1 785 MHz)



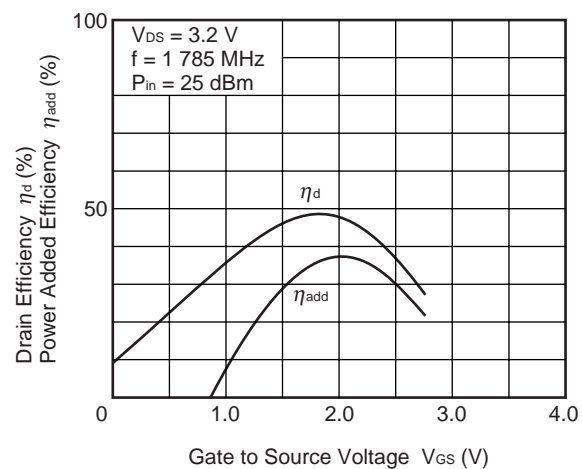
DRAIN EFFICIENCY, POWER ADDED
EFFICIENCY vs. INPUT POWER



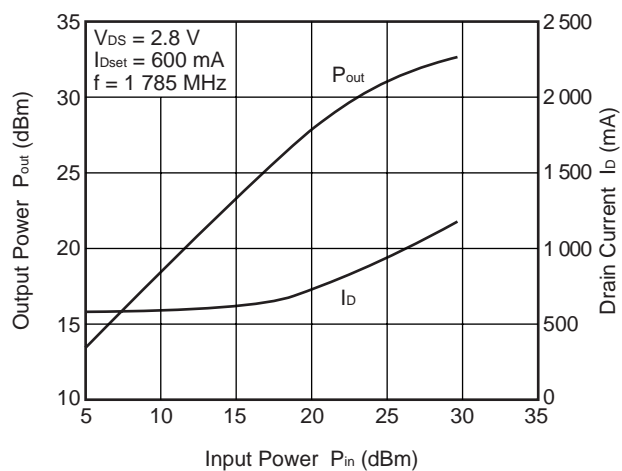
OUTPUT POWER, DRAIN CURRENT
vs. GATE TO SOURCE VOLTAGE



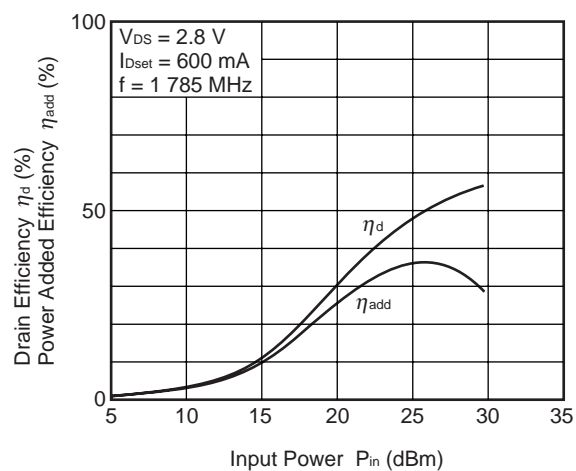
DRAIN EFFICIENCY, POWER ADDED
EFFICIENCY vs. GATE TO SOURCE VOLTAGE



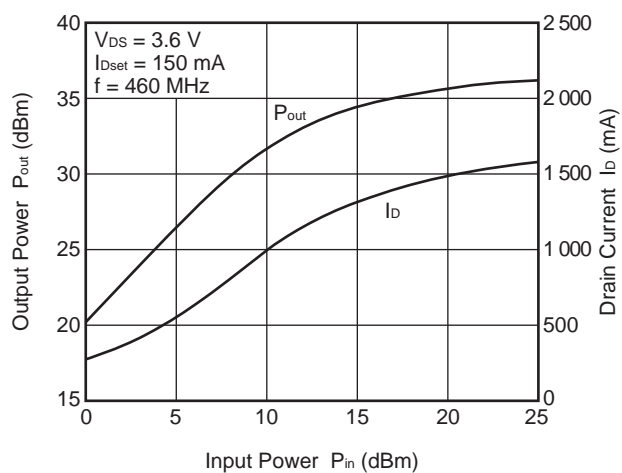
OUTPUT POWER, DRAIN CURRENT
vs. INPUT POWER (1 785 MHz)



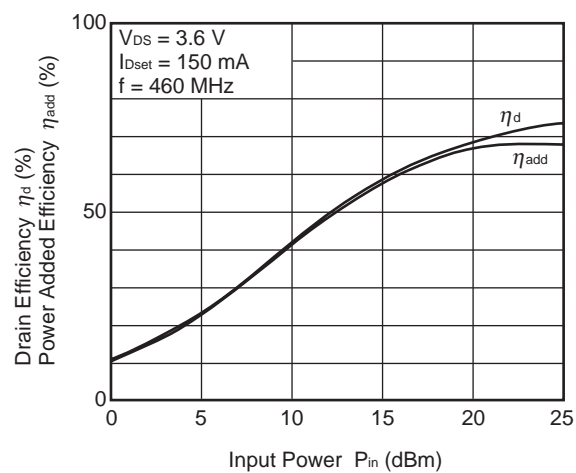
DRAIN EFFICIENCY, POWER ADDED
EFFICIENCY vs. INPUT POWER



OUTPUT POWER, DRAIN CURRENT
vs. INPUT POWER (460 MHz)



DRAIN EFFICIENCY, POWER ADDED
EFFICIENCY vs. INPUT POWER



Remark The graphs indicate nominal characteristics.

S-PARAMETERS

S-parameters/Noise parameters are provided on the NEC Compound Semiconductor Devices Web site in a form (S2P) that enables direct import to a microwave circuit simulator without keyboard input.

Click here to download S-parameters.

[RF and Microwave] → [Device Parameters]

URL <http://www.csd-nec.com/>

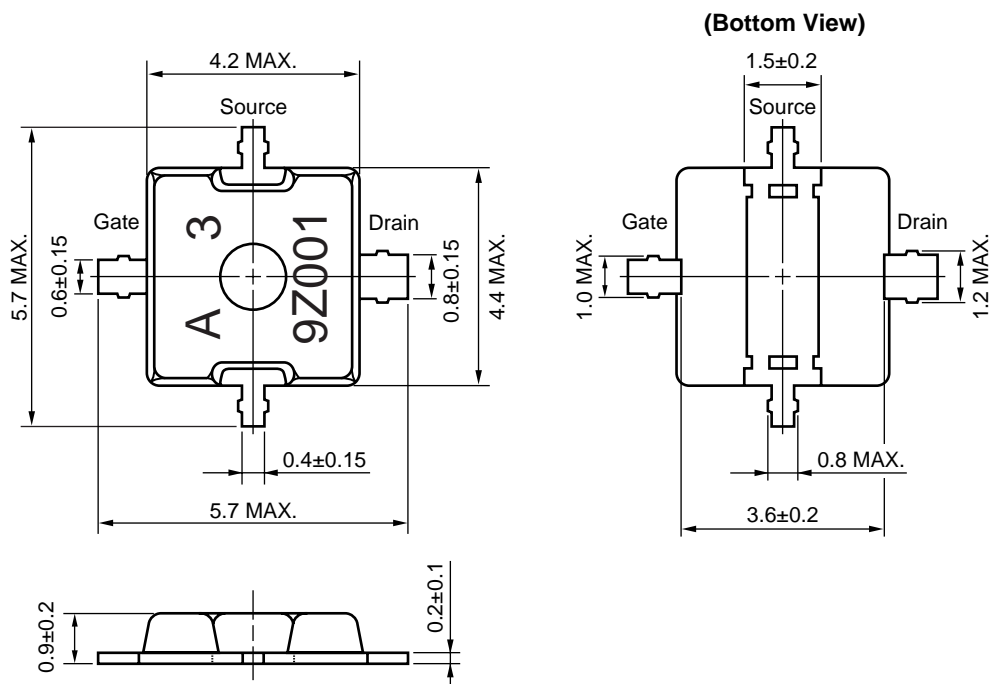
LARGE SIGNAL IMPEDANCE ($V_{DS} = 3.2 \text{ V}$, $I_{Dset} = 600 \text{ mA}$, $P_{in} = 25 \text{ dBm}$)

f (MHz)	$Z_{in} (\Omega)$	$Z_{OL} (\Omega)$ ^{Note}
1 785	TBD	TBD

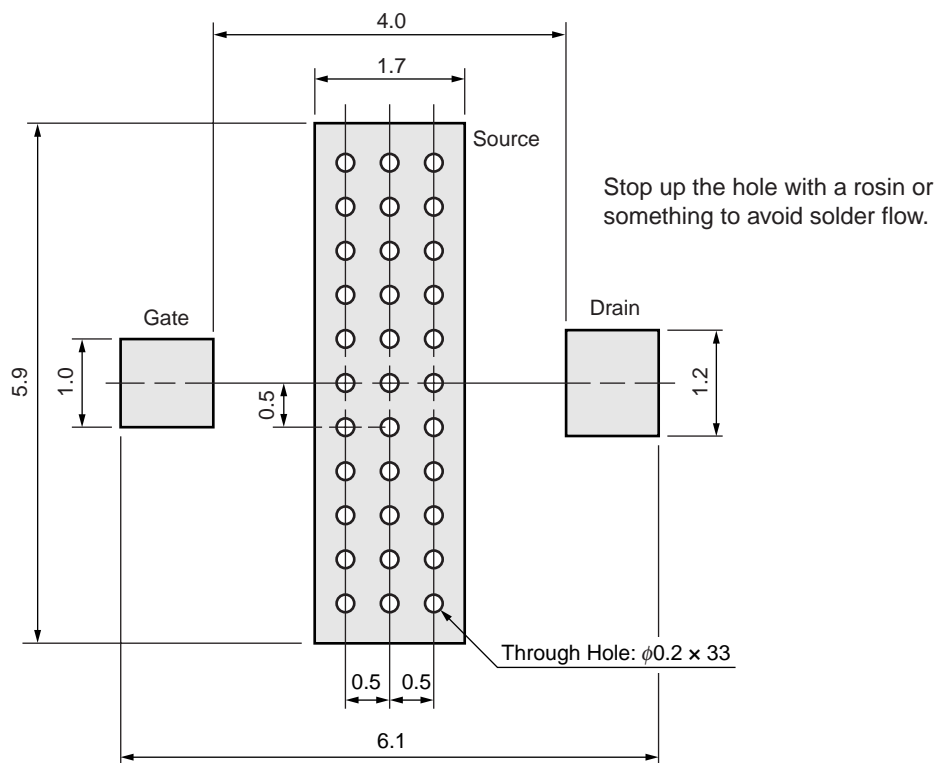
Note Z_{OL} is the conjugate of optimum load impedance at given voltage, idling current, input power and frequency.

★ PACKAGE DIMENSIONS

79A (UNIT: mm)



79A PACKAGE RECOMMENDED P.C.B. LAYOUT (UNIT: mm)



RECOMMENDED SOLDERING CONDITIONS

This product should be soldered and mounted under the following recommended conditions. For soldering methods and conditions other than those recommended below, contact your nearby sales office.

Soldering Method	Soldering Conditions	Condition Symbol
Infrared Reflow	Peak temperature (package surface temperature) : 260°C or below Time at peak temperature : 10 seconds or less Time at temperature of 220°C or higher : 60 seconds or less Preheating time at 120 to 180°C : 120±30 seconds Maximum number of reflow processes : 3 times Maximum chlorine content of rosin flux (% mass) : 0.2%(Wt.) or below	IR260
VPS	Peak temperature (package surface temperature) : 215°C or below Time at temperature of 200°C or higher : 25 to 40 seconds Preheating time at 120 to 150°C : 30 to 60 seconds Maximum number of reflow processes : 3 times Maximum chlorine content of rosin flux (% mass) : 0.2%(Wt.) or below	VP215
Wave Soldering	Peak temperature (molten solder temperature) : 260°C or below Time at peak temperature : 10 seconds or less Preheating temperature (package surface temperature) : 120°C or below Maximum number of flow processes : 1 time Maximum chlorine content of rosin flux (% mass) : 0.2%(Wt.) or below	WS260
Partial Heating	Peak temperature (pin temperature) : 350°C or below Soldering time (per pin of device) : 3 seconds or less Maximum chlorine content of rosin flux (% mass) : 0.2%(Wt.) or below	HS350-P3

Caution Do not use different soldering methods together (except for partial heating).

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M8E 00.4-0110

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